

Search Notes

Application/Control No.

10/084,708

Examiner

Duy M. Dang

Applicant(s)/Patent under
Reexamination

IKENOUE ET AL.

Art Unit

2624

SEARCHED

| Class | Subclass | Date | Examiner |
|-------|-------------|-----------|----------|
| 382 | 100 | 5/15/2006 | DD |
| 358 | 3.28 501 | 5/15/2006 | DD |
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INTERFERENCE SEARCHED

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**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

| | DATE | EXMR |
|--|-----------|------|
| East (USPTO, JPO, EPO, DERWENT, OCR, IBM-TDB), see printouts | 5/15/2006 | DD |
| East (USPTO, OCR), see printouts | 3/30/2006 | DD |
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